## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10815106	ICHIKAWA ET AL.
Examiner	Art Unit
Chen, Shin-Hon	2131

SEARCHED						
Class	Subclass	Date	Examiner			
713	158,168,169,170,156, 175	6/8/07	S.C.			
726	10	6/6/08	S.C.			

SEARCH NOTES			
Search Notes	Date	Examiner	
USPAT, PGPUB, DERWENT, JPO, EPO (BRS search-see search history)	6/8/07	S.C.	
USPAT, PGPUB, DERWENT, JPO, EPO (updated BRS search)	6/6/08	S.C.	

INTERFERENCE SEARCH						
Class	Subclass	Date	Examiner			
713	158,168,169,170,156,175	6/6/08	S.C.			
726	10	6/6/08	S.C.			

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